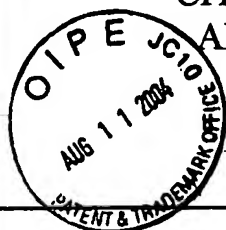


INFORMATION DISCLOSURE CITATION IN AN APPLICATION



(PTO-1449)

ATTY. DOCKET NO.
50212-569

SERIAL NO.
10764,497

APPLICANT
Manabu SHIOZAKI, et al.

FILING DATE
January 27, 2004

GROUP
Not yet assigned

2872

U.S. PATENT DOCUMENTS

EXAMINER'S INITIALS	CITE NO.	Document Number Number-Kind Codes (if known)	Publication Date MM-DD-YYYY	Name of Patentee or Applicant of Cited Document	Pages, Columns, Lines, Where Relevant Passages or Relevant Figures Appear
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FOREIGN PATENT DOCUMENTS

EXAMINER'S INITIALS	CITE NO.	Foreign Patent Document Country Codes - Number - Kind Codes (if known)	Publication Date MM-DD-YYYY	Name of Patentee or Applicant of Cited Document	Pages, Columns, Lines Where Relevant Figures Appear	Translation	
						Yes	No

OTHER ART (Including Author, Title, Date, Pertinent Pages, Etc.)

EXAMINER'S INITIALS	CITE NO.	Include name of the author (in CAPITAL LETTERS), title of the article (when appropriate), title of the item (book, magazine, journal, serial, symposium, catalog, etc.), date, page(s), volume-issue number(s), publisher, city and/or country where published.
FA		KASHIKO KODATE; "Development of Diffractive Optics and Future Challenges"; Japan Women's Bulletin, Department of Mathematical and Physical Sciences, Vol. 10; c. 2002; pp. 7-24
RO		HENDRIK J. GERRITSEN et al.; "Rectangular Surface-Relief Transmission Gratings with a Very Large First-Order Diffraction Efficiency (~95%) for Unpolarized Light"; Applied Optics, Vol. 37, No. 25; c. 1998; pp. 5823 - 5829
		Summary of Workshop on Nanotech-Material Associated with Devices, c. 2002; pp. 125 - 127
		Nanotech Weekly, Vol. 1133, c. 2003; pp. 6-21

EXAMINER

DATE CONSIDERED






FAVEZ ASSEF

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*: incomplete information: Author, title, place of publication.
see 37 CFR 1.98(b)

INFORMATION DISCLOSURE CITATION IN AN APPLICATION (PTO-1449)				ATTY. DOCKET NO. 50212-569		SERIAL NO. 10/764,497	
				APPLICANT Manabu SHIOZAKI, et al.			
				FILING DATE January 27, 2004		GROUP 6260	
U.S. PATENT DOCUMENTS							
EXAMINER'S INITIALS	CITE NO.	Document Number Number-Kind Code ² (if known)	Publication Date MM-DD-YYYY	Name of Patentee or Applicant of Cited Document	Pages, Columns, Lines, Where Relevant Passages or Relevant Figures Appear		
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		JP 2002-258034 /	09/11/2002	JAPAN SCIENCE & TECHNOLOGY CORP		JAPAN (w/English Abstract)	
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		JP 58-500916 /	06/02/1983		Corresponds with WO 83/00395		X
OTHER ART (Including Author, Title, Date, Pertinent Pages, Etc.)							
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EXAMINER FAVEZ ASBTF				DATE CONSIDERED 8/9/05			

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